Power MOSFET

–60 V, –8 A, 260 m Ω , Single P–Channel

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified
- These are Pb–Free Devices

MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	-60	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain Cur-		T _{mb} = 25°C	I _D	-8.0	А
rent R _{ΨJ-mb} (Notes 1, 2, 3, 4)	Steady	T _{mb} = 100°C		-6.0	
Power Dissipation	State	T _{mb} = 25°C	PD	38	W
$R_{\Psi J-mb}$ (Notes 1, 2, 3)		T _{mb} = 100°C		19	
Continuous Drain Cur-		T _A = 25°C	I _D	-2.1	A
rent R _{θJA} (Notes 1, 3, 4)	Steady State	$T_A = 100^{\circ}C$		-1.5	
Power Dissipation		T _A = 25°C	PD	2.3	W
$R_{\theta JA}$ (Notes 1, 3)		T _A = 100°C		1.1	
Pulsed Drain Current	$T_A = 25^{\circ}C$, $t_p = 10 \ \mu s$		I _{DM}	-24	А
Operating Junction and Storage Temperature		T _J , T _{stg}	–55 to +175	°C	
Source Current (Body Diode)		I _S	-38	А	
Single Pulse Drain-to-Source Avalanche Energy (T _J = 25°C, V _{DD} = -50 V, V _{GS} = -10 V, I _{L(pk)} = -13 A, L = 0.1 mH, R _G = 25 Ω)		E _{AS}	8.5	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		ΤL	260	°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit	
Junction-to-Mounting Board (top) - Steady State (Note 2 and 3)	$R_{\Psi J-mb}$	3.9	°C/W	
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	66		

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Psi (Ψ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.

3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.

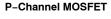
4. Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

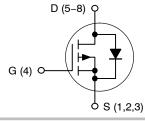


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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX		
–60 V	260 mΩ @ –10 V	-8 A		
	380 mΩ @ −4.5 V	-0 A		







= Pb-Free Package
(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NVTFS5124PLTAG	WDFN8 (Pb-Free)	1500/Tape & Reel
NVTFS5124PLTWG	WDFN8 (Pb-Free)	5000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

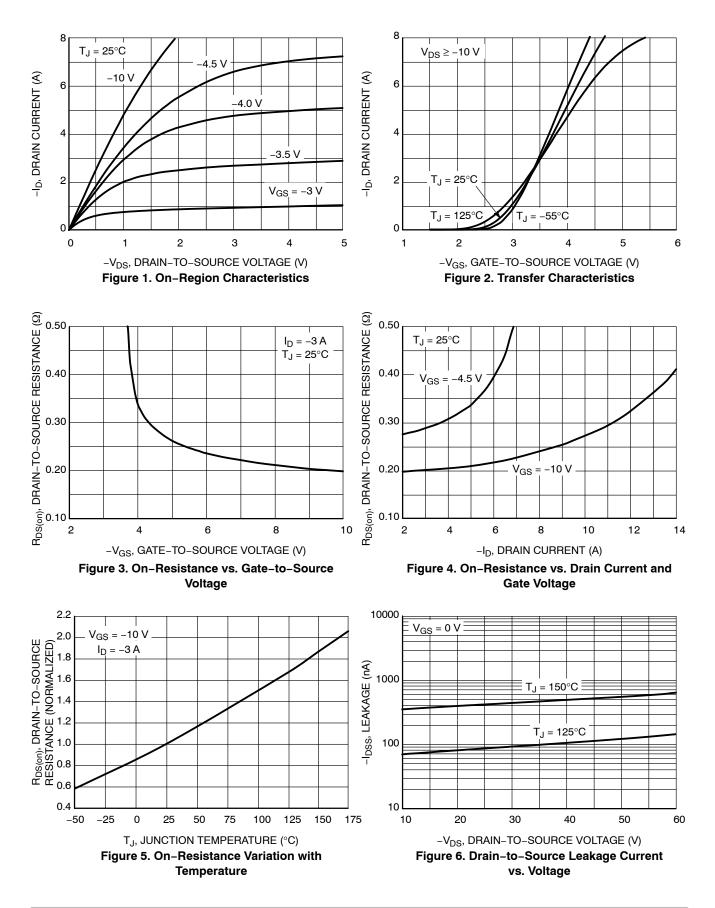
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ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

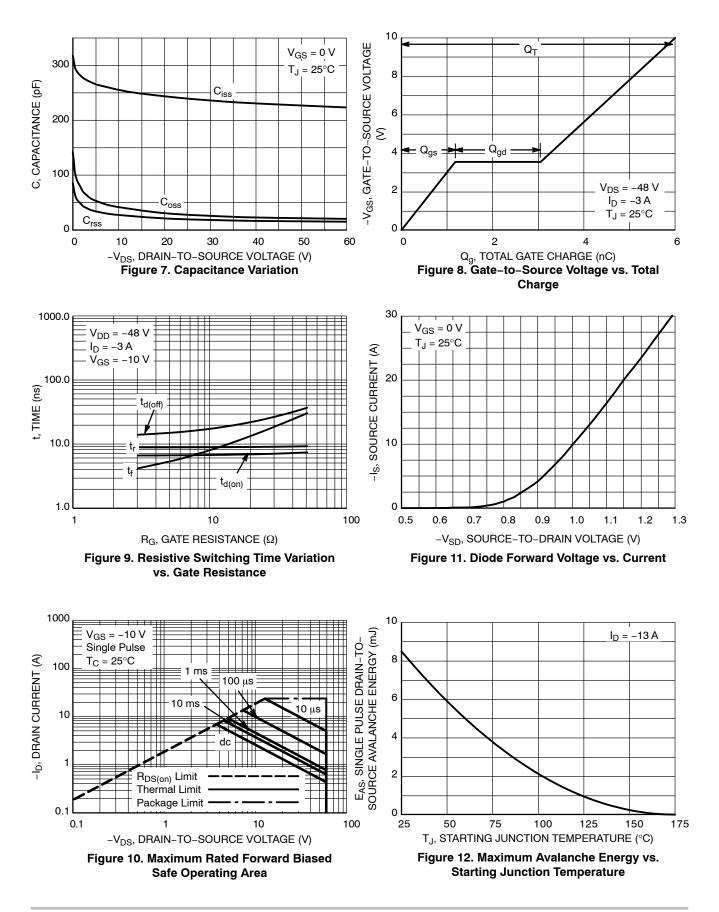
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = -250 μA		-60			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$			-1.0	μA
		$V_{\rm DS} = -60 \rm V$	T _J = 125°C			-10	1
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	= –250 μA	-1.5		-2.5	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = -10 V,	_D = -3 A		200	260	mΩ
		V _{GS} = -4.5 V,	I _D = -3 A		290	380	
Forward Transconductance	9 FS	V _{DS} = -15 V,	_D = -5 A	4			S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}	V_{GS} = 0 V, f = 1.0 MHz, V_{DS} = –25 V			250		
Output Capacitance	C _{oss}				27		pF
Reverse Transfer Capacitance	C _{rss}				17		
Total Gate Charge	Q _{G(TOT)}				3.5		1
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = -4.5 \text{ V}, V_{DS} = -48 \text{ V},$ $I_D = -3 \text{ A}$ $V_{GS} = -10 \text{ V}, V_{DS} = -48 \text{ V},$ $I_D = -3 \text{ A}$			0.4		nC
Gate-to-Source Charge	Q _{GS}				1.2		
Gate-to-Drain Charge	Q _{GD}				1.9		
Total Gate Charge	Q _{G(TOT)}				6		
SWITCHING CHARACTERISTICS (No	te 6)						-
Turn-On Delay Time	t _{d(on)}				7		ns
Rise Time	t _r	V _{GS} = -4.5 V, V _E	_{0S} = -48 V,		14		
Turn-Off Delay Time	t _{d(off)}	$I_{\rm D} = -3 \rm A, R_{\rm G}$	= 2.5 Ω		13		
Fall Time	t _f				10		1
DRAIN-SOURCE DIODE CHARACTER	ISTICS						
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V,$ $I_{S} = -3 A$	$T_J = 25^{\circ}C$		-0.87	-1.0	V
			T _J = 125°C		-0.74		
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V}, \\ dI_S/dt = 100 \text{ A}/\mu\text{s}, \\ I_S = -3 \text{ A}$			17		ns
Charge Time	t _a				14		-
Discharge Time	t _b				3		
Reverse Recovery Charge	Q _{RR}				19		nC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

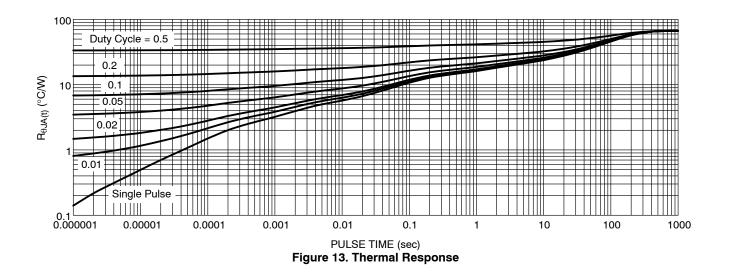
TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

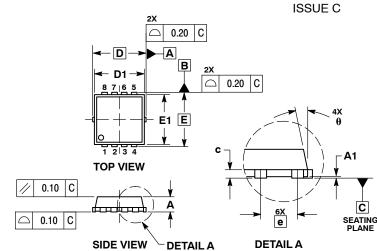


PACKAGE DIMENSIONS

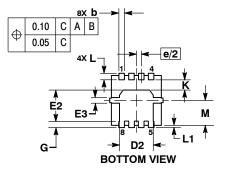
WDFN8 3.3x3.3, 0.65P CASE 511AB

NOTES:

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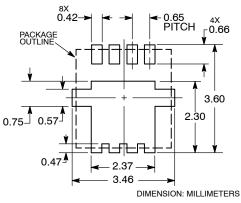


I ES: DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS. MILLIMETERS INCHES MIN NOM MIN DIM ΜΔΧ NOM ΜΔΧ 0.028 0.030 0.031 Α 0.70 0.75 0.80 A1 0.00 0.05 0.000 0.002 b 0.23 0.30 0.40 0.009 0.012 0.016 с 0.15 0.20 0.25 0.006 0.008 0.010 D .30 BS0 0.130 BSC D1 3.15 0 116 0.120 0 1 2 4 2.95 3.05 D2 1.98 2.11 2.24 0.078 0.083 0.088 0.130 BSC E .30 BSC E1 2.95 3.05 3.15 0.116 0.120 0.124 E2 1.47 1.60 1.73 0.058 0.063 0.068 0.009 0.012 0.016 E3 0.23 0.30 0.40 0.026 BSC е 0.65 BSC G 0.30 0.51 0.012 0.016 0.020 0.41 κ 0.64 0.025 0.017 0.022 L 0.30 0.43 0.56 0.012 0.002 0.005 0.008 L1 0.06 0.13 0.20 М 1.40 1.60 1.50 0.055 0.059 0.063 θ 0 ° 12 ° 0 0 12 °





SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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